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INFORMATION DISCLOSURE STATEMENT <i>(Use several sheets if necessary)</i>		U.S. Department of Commerce Patent & Trademark Office	Attorney Docket No. 218TG/48722	Serial No. 09/524,755
		Applicant: Peter HEINRICH et al.		
		Filing Date March 13, 2000	Group	

U.S. PATENT DOCUMENTS							
Examiner Initial		Document Number	Date	Name	Class	Sub-Class	Filing Date (if appropriate)
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FOREIGN PATENT DOCUMENTS							
Examiner Initial		Document Number	Date	Country	Class	Sub-Class	TRANSLATION
							Yes No
	AK						
	AL						
	AM						
	AN						
	AO						
	AP						

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

SCE	AQ	VII Finnish Conference on Physics in Industry, Nov. 1-2, 1995, Tampere, Finland entitled "Real-Time Optical Spray Pattern Diagnostics for Thermal Spraying" by T. Lehtinen et al.
SCE	AR	Proceedings of the XXX Annual Conference of the Finnish Physical Society entitled "In-Flight Particle Visualisation in Thermal Plasma Spraying Using an Intensified CCD Camera" by T. Lehtinen et al.
SCE	AS	Proceedings of the XXXI Annual Conference of the Finnish Physical Society, March 13-15, 1997, Helsinki, Finland entitled "In-Flight Particle Concentration Measurements in Thermal Plasma Spraying Using a CCD Camera" by T. Lehtinen et al.

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FORM PTO-1440. U. S. Department of Commerce Patent & Trademark Office INFORMATION DISCLOSURE STATEMENT <i>(Use several sheets if necessary)</i>		Attorney Docket No. 218TG/48722	Serial No. 09/524,755
		Applicant: Peter HEINRICH et al.	
		Filing Date March 13, 2000	Group

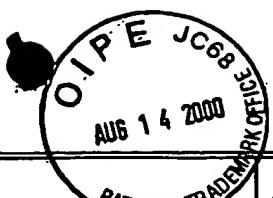
U. S. PATENT DOCUMENTS							
Examiner Initial		Document Number	Date	Name	Class	Sub-Class	Filing Date (if appropriate)
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Examiner Initial		Document Number	Date	Country	Class	Sub-Class	TRANSLATION
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OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)							
<i>Sce</i>	AQ	<i>Optics Day '97 - Proceedings Finnish Optical Society Tampere University of Technology, Feb. 21, 2997, Tampere, Finland</i> entitled "Optical Spray Pattern Diagnostics for Thermal Spraying by T. Lehtinen et al.					
	AR						
	AS						
EXAMINER <i>Sheila Clemons</i>				DATE CONSIDERED <i>4/18/04</i>			
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Form PTO-1449 U.S. Department of Commerce Patent & Trademark Office		Atty. Docket No. 218TG/48722	Serial No. 09/524,755
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)		Applicant: Peter Heinrich et al.	
		Filing Date: March 13, 2000	Group

U.S. PATENT DOCUMENTS

Examiner Initial		Document Number	Date	Name	Class	Sub-Class	Filing Date (if appropriate)
SCL	AA	5,047,612	1991	Savkar et al.	29	12147	—
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FOREIGN PATENT DOCUMENTS

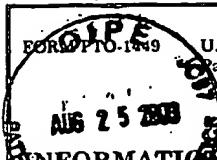
		Document	Date	Country	Class	Sub-class	Translation Yes No
SCL	AK	EP08269672	1996	Europe	—	—	Abstract
↓	AL	EP0955387A1	1999	Europe	—	—	Abstract
↓	AM	DE3515209A1	1985	Germany	—	—	Abstract
SCL	AN	DE19820195A1	1999	Germany	—	—	Abstract
	AO						
	AP						

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

SCL	AQ	Klaus Voss and Herbert Suesse, "Invariant Fitting of Planar Objects by Primitives", 1997, pgs. 80-84.
	AR	
	AS	

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U.S. Department of Commerce
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INFORMATION DISCLOSURE
STATEMENT
(Use several sheets if necessary)

Attorney Docket No.
218TG.48722

Serial No.
09/524,755

Applicant: Peter HEINRICH, et al.

Filing Date
March 13, 2000

Group

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FOREIGN PATENT DOCUMENTS

Examiner Initial	Document Number	Date	Name	Class	TRANSLATION	
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AK						
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AO						
AP						

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

SCL	AQ	T. LEHTINEN, et al., "Correlations Between In-Flight Particle Concentrations and Coating Properties in Atmospheric Plasma Spraying of Alumina" pages 525-530				
	AR					
	AS					

EXAMINER *Sheel Umar*

DATE CONSIDERED

1/24/04

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